

Search Notes



Application/Control No.

10/735,732

Examiner

Dawn Garrett

Applicant(s)/Patent under Reexamination

TOKUDA ET AL.

Art Unit

1774

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|---------|----------|
| 428 | 690 | 3/17/06 | DS |
| 428 | 917 | | |
| 313 | 504 | | |
| 313 | 506 | ↓ | ↓ |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR. |
|--------------------------------------------|----------|-------|
| EAST search (see printout) | 3/16/06 | DS |
| EAST search (see printout) | 3/17/06 | DS |
| Stic structure search (see printout) | 2/1/06 | DS |
| Prior search reviewed | 7/28/06 | DS |
| EAST search (see printout) | 12/20/06 | DS |
| EAST search (see printout) | 4/4/07 | DS |
| | | |
| | | |
| | | |